

IN THE CLAIMS

1. (Currently Amended) An IC card comprising:

an IC module which comprises an IC chip mounted on an insulating substrate having an antenna coil, and a chip reinforcing plate provided on at least an IC mounted surface of said insulating substrate; and

a core layer comprising a plurality of sheet materials having said IC module disposed therebetween,

wherein, in said plurality of sheet materials, at least the sheet materials adjacent to said IC module have a through hole for containing therein said IC chip, formed in a region corresponding to an IC mounted portion of said IC module,

wherein said plurality of sheet materials constituting said core layer comprise at least a pair of inner core sheets adjacent to said IC module,

wherein a relationship $A = (B1 + C1) \pm 30 \mu\text{m}$ is satisfied,

where A (μm) represents the sum of heights of said through holes, $B1$ (μm) represents a projection height on an IC mounted surface of said IC module, and $C1$ (μm) represents a projection height on an IC non-mounted surface of said IC module.

2. (Original) The IC card according to claim 1, wherein a relationship $(B1 + C1) - 20 \mu\text{m} \leq A \leq (B1 + C1) + 10 \mu\text{m}$ is satisfied.

3. (Original) The IC card according to claim 1, wherein a relationship $B = B1 \pm 30 \mu\text{m}$ is satisfied where B (μm) represents a height of said through hole on the side of the IC mounted surface of said IC module.

4. (Original) The IC card according to claim 1, wherein a relationship $C = C1 \pm 30 \mu\text{m}$ is satisfied where C (μm) represents a height of said through hole on the side of the IC non-mounted surface of said IC module.

5. (Original) The IC card according to claim 1, wherein a relationships $B = B1 \pm 30 \mu\text{m}$, and $C = C1 \pm 30 \mu\text{m}$ are satisfied where B (μm) represents a height of said through hole on the side of the IC mounted surface of said IC module, and C (μm) represents a height of said through hole on the side of the IC non-mounted surface of said IC module.

6. (Currently Amended) The IC card according to claim 1, wherein ~~said plurality of sheet materials constituting said core layer comprise at least a pair of inner core sheets adjacent to said IC module, and an outer core sheet stacked on at least one of said pair of inner core sheets.~~

7. (Original) The IC card according to claim 1, wherein said core layer has a rewritable display layer formed on at least one surface of said core layer.

8. (Original) The IC card according to claim 1, wherein, in said sheet materials constituting said core layer, at least a pair of sheet materials having said IC module disposed therebetween includes a material comprising a copolymer of terephthalic acid, cyclohexanedimethanol and ethylene glycol, and polycarbonate.

9. (Original) The IC card according to claim 1, wherein said sheet materials constituting said core layer comprise a no-chlorine-containing material.

10. (Currently Amended) An IC card comprising:
an IC module which comprises an IC chip mounted on an insulating substrate having an antenna coil, and a chip reinforcing plate provided on at least an IC mounted surface of said insulating substrate; and

a core layer comprising a plurality of sheet materials having said IC module disposed therebetween,

wherein, in said plurality of sheet materials, at least the sheet materials adjacent to said IC module have a through hole for containing therein said IC chip, formed in a region corresponding to an IC mounted portion of said IC module,

wherein said plurality of sheet materials constituting said core layer comprise at least a pair of inner core sheets adjacent to said IC module,

wherein a relationships $B = B1 \pm 30 \mu\text{m}$, and $C = C1 \pm 30 \mu\text{m}$ are satisfied,

where $B1 (\mu\text{m})$ represents a projection height on an IC mounted surface of said IC module, $C1 (\mu\text{m})$ represents a projection height on an IC non-mounted surface of said IC module, $B (\mu\text{m})$ represents a height of said through hole on the side of the IC mounted surface of said IC module, and $C (\mu\text{m})$ represents a height of said through hole on the side of the IC non-mounted surface of said IC module.

11. (Original) The IC card according to claim 10, wherein a relationship $A = (B1 + C1) \pm 30 \mu\text{m}$ is satisfied where $A (\mu\text{m})$ represents the sum of heights of said through holes.

12. (Original) The IC card according to claim 10, wherein a relationship $(B1 + C1) - 20 \mu\text{m} \leq A \leq (B1 + C1) + 10 \mu\text{m}$ is satisfied.

13. (Currently Amended) The IC card according to claim 10, wherein ~~said plurality of sheet materials constituting said core layer comprise at least a pair of inner core sheets adjacent to said IC module, and an outer core sheet stacked on at least one of said pair of inner core sheets.~~

14. (Original) The IC card according to claim 10, wherein said core layer has a rewritable display layer formed on at least one surface of said core layer.

15. (Original) The IC card according to claim 10, wherein, in said sheet materials constituting said core layer, at least a pair of sheet materials having said IC module disposed therebetween comprise a material comprising a copolymer of terephthalic acid, cyclohexanedimethanol, and ethylene glycol and polycarbonate.

16. (Original) The IC card according to claim 10, wherein said sheet materials constituting said core layer comprise a no-chlorine-containing material.

17. (Previously Presented) An IC card comprising:

an IC module which comprises an IC chip mounted on an insulating substrate having an antenna coil, and a chip reinforcing plate provided on at least an IC mounted surface of said insulating substrate; and

a core layer comprising a plurality of sheet materials having said IC module disposed therebetween,

wherein, in said plurality of sheet materials, at least the sheet materials adjacent to said IC module have a through hole for containing therein said IC chip, formed in a region corresponding to an IC mounted portion of said IC module,

wherein $A = (B_1 + C_1)$, where A (μm) represents the sum of heights of said through holes, B_1 (μm) represents a projection height on an IC mounted surface of said IC module, and C_1 (μm) represents a projection height on an IC non-mounted surface of said IC module, wherein A is no greater or no less than 30 microns from the sum of B_1 and C_1 .

18. (Previously Presented) The IC card according to claim 17, wherein a relationship $(B_1 + C_1) - 20 \mu\text{m} \leq A \leq (B_1 + C_1) + 10 \mu\text{m}$ is satisfied.

19. (Previously Presented) The IC card according to claim 17, wherein a relationship $B = B_1 \pm 30 \mu\text{m}$ is satisfied where B (μm) represents a height of said through hole on the side of the IC mounted surface of said IC module.

20. (Previously Presented) The IC card according to claim 17, wherein a relationship $C = C_1 \pm 30 \mu\text{m}$ is satisfied where C (μm) represents a height of said through hole on the side of the IC non-mounted surface of said IC module.